

N and P-Channel Enhancement Mode Power MOSFET

Description

The HM4618A uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge . The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

General Features

N-Channel

 $V_{DS} = -40V, ID = -13A$

 $R_{DS(ON)}$ <15m Ω @ VGS=-10V

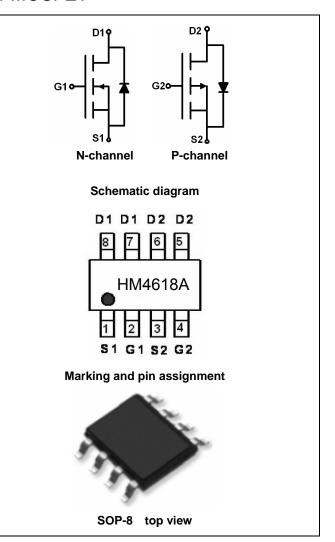
 $R_{DS(ON)}$ <18m Ω @ VGS=-4.5V

P-Channel

V_{DS} =40V,ID =15A

 $R_{DS(ON)}$ <13m Ω @ VGS=10V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM4618A	HM4618A	SOP-8	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Parame	Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage		V _{DS}	-40	40	V
Gate-Source Voltage		V _{GS}	±20	±20	V
Continuous Drain Current	T _A =25℃		-13	15	А
Continuous Drain Current	T _A =70°C	I _D	-9	10	
Pulsed Drain Current (Note 1)		I _{DM}	50	50	Α
Maximum Power Dissipation T _A =25℃		P _D	2.5	3	W
Operating Junction and Storage Temperature Range		T_{J} , T_{STG}	-55 To 150	-55 To 150	$^{\circ}$

Thermal Characteristic



Thermal Resistance,Junction-to-Ambient (Note2)	R _{0JA}	N-Ch	62.5	°C/W
Thermal Resistance, Junction-to-Ambient (Note2)	$R_{ heta JA}$	P-Ch	62.5	°C/W

N-CH Electrical Characteristics (T_A=25 $^{\circ}\text{C}\,\text{unless}$ otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics			<u> </u>			
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-40	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-40V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)	·					
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-1.3	-2	-2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-12A	-	12	15	mΩ
Forward Transconductance	g Fs	V _{DS} =-15V,I _D =-10A	35	-	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C _{lss}	\/ 00\/\/ 0\/	-	2800	-	PF
Output Capacitance	C _{oss}	V_{DS} =-20V, V_{GS} =0V, F=1.0MHz	-	320	-	PF
Reverse Transfer Capacitance	C _{rss}	r-1.0WIHZ	-	220	-	PF
Switching Characteristics (Note 4)	·					
Turn-on Delay Time	t _{d(on)}		-	11	-	nS
Turn-on Rise Time	t _r	V_{DD} =-20 V , $,R_L$ =2 Ω	-	75	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =-10 V , R_{GEN} =6 Ω	-	89	-	nS
Turn-Off Fall Time	t _f		-	35	-	nS
Total Gate Charge	Qg	V - 20VI - 42A	-	40	-	nC
Gate-Source Charge	Q _{gs}	V_{DS} =-20V, I_{D} =-12A, V_{GS} =-10V	-	6	-	nC
Gate-Drain Charge	Q_{gd}	v _{GS} =-10v	-	12	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-12A	-	-	1.2	V
Diode Forward Current (Note 2)	I _S		-	-	-13	Α



P-CH Electrical Characteristics (T_A=25 $^{\circ}\text{C}\,\text{unless}$ otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	•		•			
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	40	45	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V,V _{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)	•		•			
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1.2	1.6	2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =15A	-	7.3	13	mΩ
Forward Transconductance	g fs	V _{DS} =10V,I _D =15A	15	-	-	S
Dynamic Characteristics (Note4)	•		•			
Input Capacitance	C _{lss}	V 00V/V 0V/	-	1800	-	PF
Output Capacitance	C _{oss}	V_{DS} =20V, V_{GS} =0V, F=1.0MHz	-	280	-	PF
Reverse Transfer Capacitance	C _{rss}	F-1.0WHZ	-	190	-	PF
Switching Characteristics (Note 4)	•		•			
Turn-on Delay Time	t _{d(on)}		-	6.4	-	nS
Turn-on Rise Time	t _r	V_{DD} =20V, I_D =2A, R_L =1 Ω	-	17.2	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10 V , R_{G} =3 Ω	-	29.6	-	nS
Turn-Off Fall Time	t _f		-	16.8	-	nS
Total Gate Charge	Qg	\/ -20\/ -15A	-	29		nC
Gate-Source Charge	Q_{gs}	V_{DS} =20V, I_D =15A, V_{GS} =10V	-	4.5		nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	6.4		nC
Drain-Source Diode Characteristics	•		•			
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =10A	-		1.2	V
Diode Forward Current (Note 2)	Is		-	-	15	Α
Reverse Recovery Time	t _{rr}	TJ = 25°C, IF = 15A	-	29	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	26	-	nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production



N- Channel Typical Electrical and Thermal Characteristics (Curves)

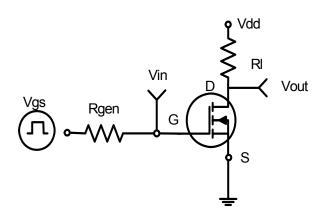


Figure 1:Switching Test Circuit

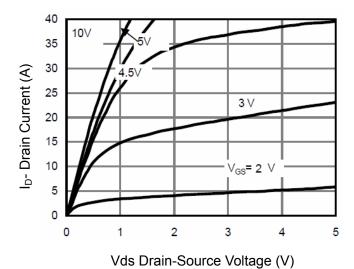


Figure 3 Output Characteristics

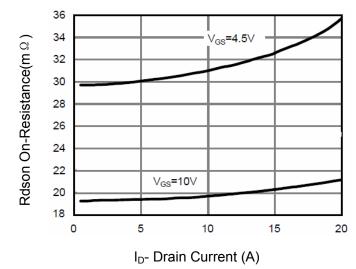


Figure 5 Drain-Source On-Resistance

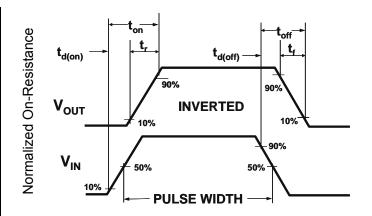


Figure 2:Switching Waveforms

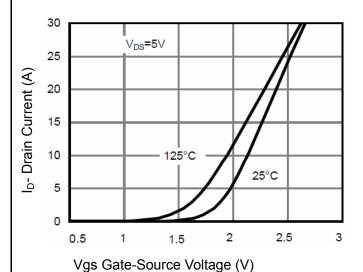


Figure 4 Transfer Characteristics

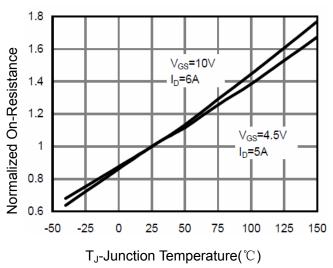


Figure 6 Drain-Source On-Resistance



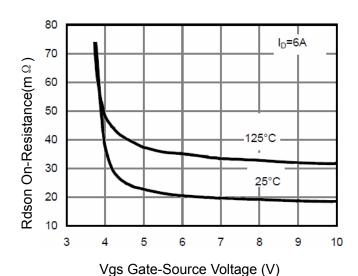


Figure7 Rdson vs Vgs

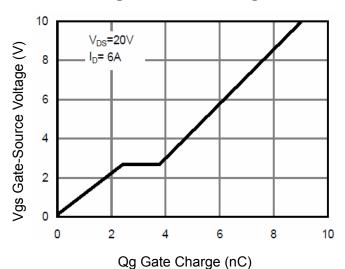


Figure 9 Gate Charge

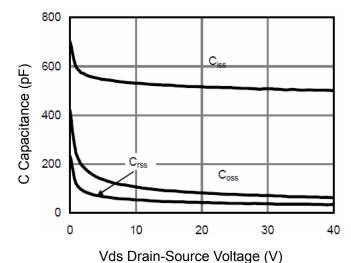
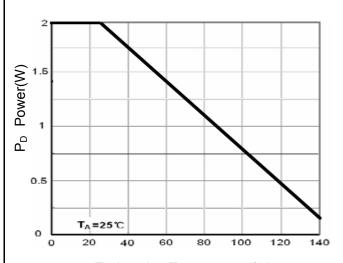


Figure 11 Capacitance vs Vds



 $T_{J}\text{-Junction Temperature}({}^{\circ}\!\mathbb{C})$

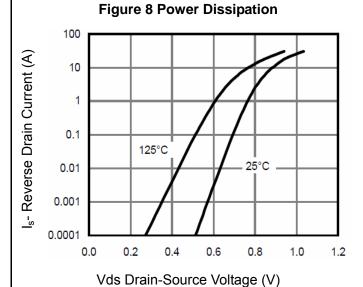
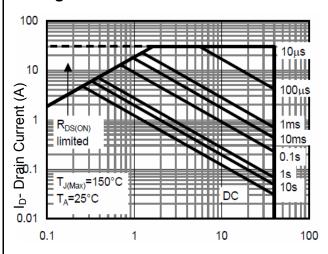


Figure 10 Source- Drain Diode Forward



Vds Drain-Source Voltage (V)

Figure 12 Safe Operation Area



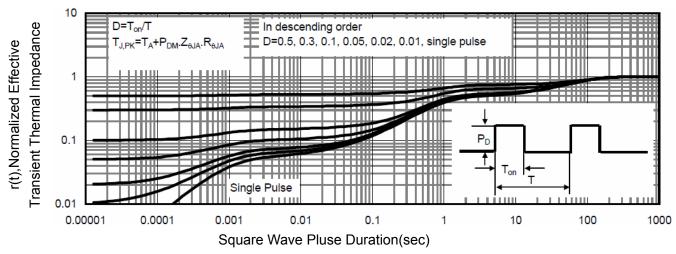
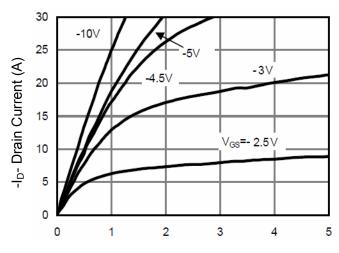


Figure 13 Normalized Maximum Transient Thermal Impedance

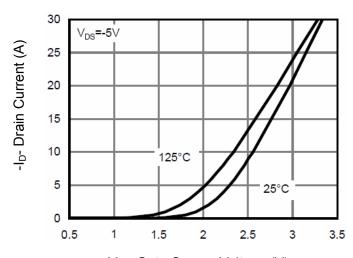


P- Channel Typical Electrical and Thermal Characteristics (Curves)



-Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics



-Vgs Gate-Source Voltage (V)

Figure 2 Transfer Characteristics

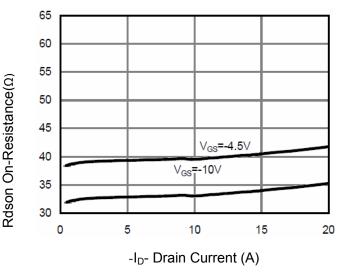


Figure 3 Rdson- Drain Current

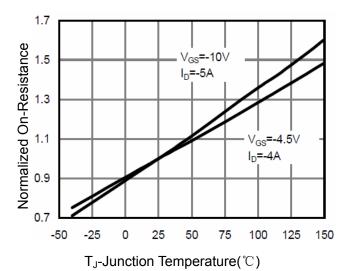


Figure 4 Rdson-Junction Temperature

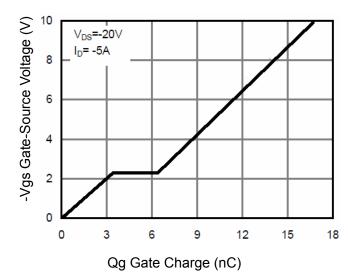


Figure 5 Gate Charge

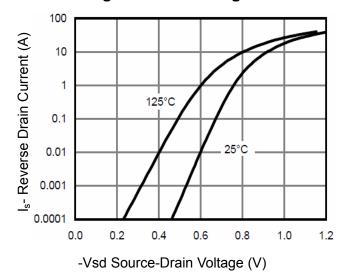
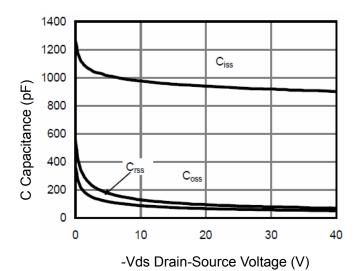


Figure 6 Source- Drain Diode Forward





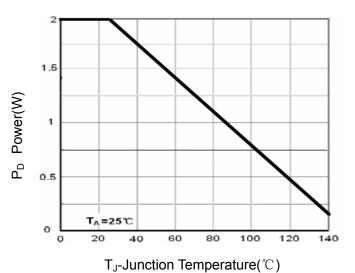


Figure 9 Power Dissipation

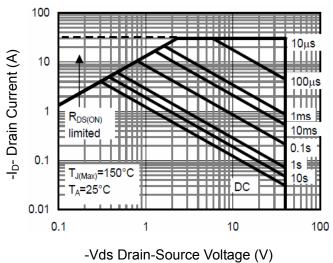


Figure 7 Capacitance vs Vds

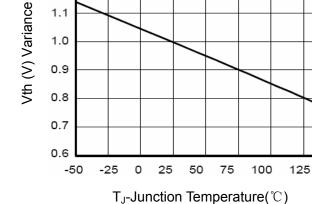
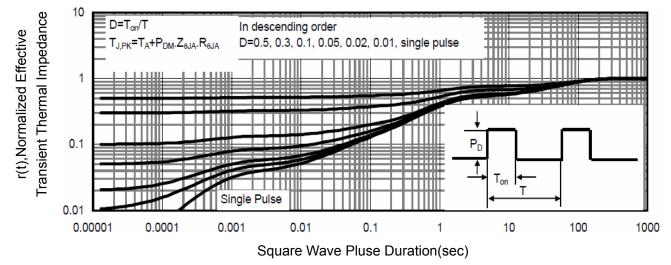


Figure 8 Safe Operation Area

Figure 10 V_{GS(th)} vs Junction Temperature

150



1.3

1.2

1.1

1.0

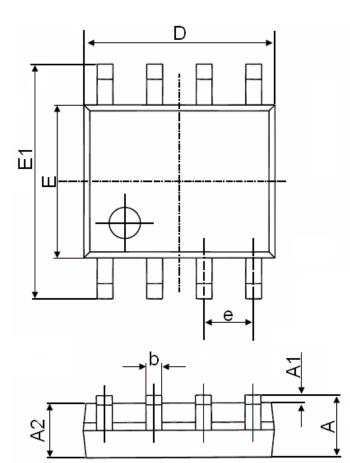
0.9

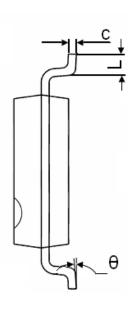
V_{DS}=V_{GS} I_D=-250μΑ

Figure 11 Normalized Maximum Transient Thermal Impedance



SOP-8 Package Information





Symbol	Dimensions	In Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
Е	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.270(BSC)		0.050(BSC)		
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



ATTENTION:

- Any and all H&M SEMI products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your H&M SEMI representative nearest you before using any H&M SEMI products described or contained herein in such applications.
- H&M SEMI assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all H&M SEMI products described or contained herein.
- Specifications of any and all H&M SEMI products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- H&M Semiconductor CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all H&M SEMI products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of H&M Semiconductor CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. H&M SEMI believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the H&M SEMI product that you intend to use.
- This catalog provides information as of Sep.2010. Specifications and information herein are subject to change without notice.